R&S®RTB 2 SERIES OSCILLOSCOPE

Specifications



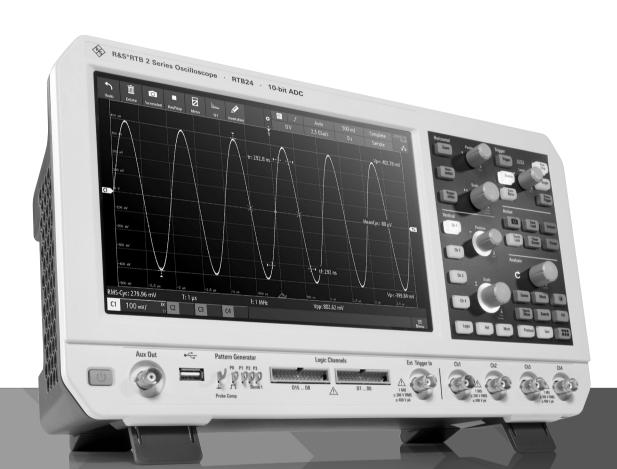
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Specifications
Version 01.01

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Definitions

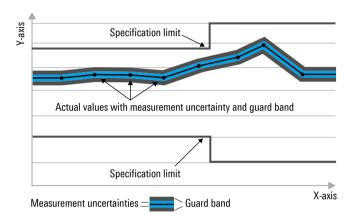
Genera

Product data applies under the following conditions:

- Three hours of storage at ambient temperature followed by 30 minutes of warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- · All internal automatic adjustments performed, if applicable

Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as <, <, >, \ge , \pm or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of measuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value, e.g. dimensions or resolution of a setting parameter. Compliance is ensured by design.

Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter, e.g. nominal impedance. In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In line with the 3GPP standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bit per second (Gbps), million bit per second (Mbps), thousand bit per second (kbps), million symbols per second (Msps) or thousand symbols per second (ksps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Mbps, ksps, ksps and Msample/s are not SI units.

Base unit

Vertical system

Input channels	R&S®RTB22	2 channels
	R&S®RTB24	4 channels
Input impedance	R&S®RTB22, R&S®RTB24	$1 M\Omega \pm 2 \%$ with $9 pF \pm 2 pF$ (meas.)
Analog bandwidth (-3 dB)	R&S®RTB22 and R&S®RTB24	> 70 MHz
, ,	R&S®RTB22 with -B221 option and	> 100 MHz
	R&S®RTB24 with -B241 option	
	R&S®RTB22 with -B222 option and	> 200 MHz
	R&S®RTB24 with -B242 option	
	R&S®RTB22 with -B223 option and	> 300 MHz
	R&S®RTB24 with -B243 option	
Lower frequency limit (-3 dB)	at AC coupling	< 2 Hz (meas.)
Analog bandwidth limits	R&S®RTB22 and R&S®RTB24	20 MHz
(max1.8 dB, min3.5 dB)		
Rise time (10 % to 90 %, calculated)	R&S®RTB22 and R&S®RTB24	< 5 ns
	R&S®RTB22 with -B221 option and	< 3.5 ns
	R&S®RTB24 with -B241 option	
	R&S®RTB22 with -B222 option and	< 1.75 ns
	R&S®RTB24 with -B242 option	
	R&S®RTB22 with -B223 option and	< 1.15 ns
	R&S®RTB24 with -B243 option	
Vertical resolution		10 bit, up to 16 bit with high-resolution
		decimation mode
Invert signal		yes
DC gain accuracy	offset and position = 0,	
	maximum operating temperature change	of ±5 °C after self-alignment
	input sensitivity > 5 mV/div	±1.5 % of full scale
	input sensitivity ≤ 5 mV/div	±2 % of full scale
Offset accuracy		±(0.5 % × offset +
		0.1 div x input sensitivity + 1 mV)
DC measurement accuracy	after adequate suppression of	±(DC gain accuracy + offset accuracy)
•	measurement noise by using high-	
	resolution sampling mode or waveform	
	averaging	
Input coupling		DC, AC (> 7 Hz)
Input sensitivity		1 mV/div to 5 V/div
Maximum input voltage		300 V (RMS), max. 400 V (V _p), derates at
		20 dB/decade to 5 V (RMS) above
		250 kHz
Position range		±5 div (depends on offset)
Offset range 1	input sensitivity	
-	200 mV/div to ≤ 5 V/div	±(40 V − position × input sensitivity)
	1 mV/div to < 200 mV/div	±(1.2 V – position × input sensitivity)
Channel-to-channel isolation	input frequency < analog bandwidth	> 50 dB
(each channel at same input sensitivity)		

Horizontal system

Timebase range		selectable between 1 ns/div and 500 s/div
Channel deskew		±500 ns
Trigger offset range	min.	memory depth/actual sampling rate
	max.	2 ³³ /actual sampling rate
Modes		normal, roll ≥ 50 ms/div
Timebase accuracy	after delivery/calibration, at +23 °C	±2.5 ppm
	during calibration interval	±3.5 ppm

Signals with non-destructive DC components that overdrive the ADC continually for long periods of time are not recommended, and may result in instrument damage.

Delta time accuracy	corresponds to time error between two edges on same acquisition and channel; waveform sample rate Fs can be obtained via SCPI command "ACQ: SRAT?"; signal amplitude greater than 5 divisions, measurement threshold set to 50 %, vertical gain 10 mV/div or greater; rise time lower than 4/Fs; waveform acquired in sample mode	±(1.19/Fs + timebase accuracy × reading) (peak) (meas.)
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Acquisition system

Maximum realtime sampling rate	normal mode	1.25 Gsample/s
	interleaved mode,	2.5 Gsample/s
	if following channels are not used	
	simultaneously:	
	 channel 1 and channel 2 	
	 channel 3 and channel 4 	
	logic probe	
Memory depth per channel	normal mode	10 Msample per channel
	interleave mode,	20 Msample per channel
	if following channels are not used	
	simultaneously:	
	 channel 1 and channel 2 	
	 channel 3 and channel 4 	
	 D7 to D0 and D15 to D8 (logic probes) 	
Acquisition modes	sample	first sample in decimation interval
	peak detect	largest and smallest sample in decimation
		interval (800 ps detection)
	high resolution	average value of all samples in decimation interval
	envelope	envelope of acquired waveforms
	average	average over a series of acquired waveforms
	envelope + peak detect	envelope of acquired waveforms with active peak detect
Number of averaged waveforms		2 to 100 000
Waveform acquisition rate	dot display, single channel, auto record length	up to 50 000 waveforms/s

Trigger system

range (min)	±5 div from center of screen
	auto, normal, single,
	n single with R&S®RTB-K15 option
time	inactive or 50 ns to 10 s
	edge, width, video, pattern, runt, rise time,
	fall time, serial bus, timeout, line
actions on trigger	pulse, sound, screenshot, save waveform,
	save reference waveform
trigger events	rising edge, falling edge, both edges
sources	
R&S [®] RTB22	channel 1, channel 2, logic channels from
	D0 to D15, external trigger input
R&S®RTB24	channel 1, channel 2, channel 3,
	channel 4, logic channels from D0 to D15,
	external trigger input
coupling (analog channels, external trigger	DC, AC,
input)	HF reject (attenuates > 50 kHz (meas.)),
	LF reject (attenuates < 50 kHz (meas.)),
	noise reject (enlarges trigger hysteresis)
	time actions on trigger trigger events sources R&S®RTB22 R&S®RTB24 coupling (analog channels, external trigger

Width trigger	trigger events	pulse width is smaller, greater, equal,
		unequal, inside interval, outside interval
	min. pulse width	6.4 ns
	max. pulse width	13.5 s
	polarity	positive, negative
	sources	
	R&S®RTB22	channel 1, channel 2, logic channels from
		D0 to D15
	R&S®RTB24	channel 1, channel 2, channel 3,
		channel 4, logic channels from D0 to D15
Video trigger	trigger events	selectable line, all lines, even frame,
		odd frame, all frames
	supported standards	PAL, NTSC, SECAM, PAL-M, SDTV 576i
	sources	
	R&S [®] RTB22	channel 1, channel 2, external trigger input
	R&S®RTB24	channel 1, channel 2, channel 3,
		channel 4, external trigger input
	sync pulse polarity	positive, negative
Pattern trigger	trigger events	logic condition between active channels
	sources	-
	R&S®RTB22	channel 1, channel 2, logic channels from
		D0 to D15
	R&S®RTB24	channel 1, channel 2, channel 3,
		channel 4, logic channels from D0 to D15
	state of channels	high, low, don't care
	logic between channels	and/or
	condition	true, false
	duration condition	smaller, greater, equal, unequal, inside
		interval, outside interval, timeout
	min. duration time	6.4 ns
	max. duration time	13.5 s
Runt trigger		triggers on pulse of positive, negative or either polarity that crosses one threshold but fails to cross a second threshold
		before crossing the first one again
Rise time, fall time	trigger events	time between the crossing of two selectable levels is lower, greater, equal, not equal
	minimum rise time	6.4 ns
	maximum rise time	13.5 s
	polarity	rising edge, falling edge, both edges
	sources	
	R&S [®] RTB22	channel 1, channel 2
	R&S®RTB24	channel 1, channel 2, channel 3, channel 4
Timeout trigger	trigger events	greater than timeout
	minimum timeout	6.4 ns
	maximum timeout	13.5 s
	polarity	stays high, stays low
	sources	
	R&S®RTB22	channel 1, channel 2, logic channels from D15 to D0
		channel 1, channel 2, channel 3,
	R&S [®] RTB24	channel 4, logic channels from D15 to D0
	R&S®RTB24 selectable trigger hysteresis	
Serial bus trigger	selectable trigger hysteresis supported standards	channel 4, logic channels from D15 to D0
Serial bus trigger	selectable trigger hysteresis supported standards R&S®RTB-K1 option	channel 4, logic channels from D15 to D0
Serial bus trigger	selectable trigger hysteresis supported standards	channel 4, logic channels from D15 to D0 small, medium, large

Trigger sensitivity	with DC, AC, LF reject	with DC, AC, LF reject		
	input sensitivity > 5 mV/div	< 0.8 div (meas.)		
	2 mV/div ≤ input sensitivity < 5 mV/div	< 1.5 div (meas.)		
	input sensitivity < 2 mV/div	< 2 div (meas.)		
	with HF reject			
	all input sensitivities	< 1 div (meas.)		
External trigger input	input impedance			
	R&S®RTB22/R&S®RTB24	1 MΩ ± 2 % with 9 pF ± 2 pF (meas.)		
	maximum input voltage at 1 mΩ	300 V (RMS), max. 400 V (V _p),		
		derates at 20 dB/decade to 5 V (RMS)		
		above 250 kHz		
	trigger level	±5 V		
	sensitivity	300 mV (V _{pp})		
	input coupling	DC, AC, LF reject, HF reject		
Trigger output (AUX OUT connector)	functionality	A pulse is generated for every acquisition		
		trigger event.		
	output voltage			
	at high impedance	0 V to 4.8 V		
	at 50 Ω	0 V to 2.4 V		
	pulse polarity	high active		
	output delay	depends on trigger settings		

Waveform measurements

Automatic measurements	measurements on channels,	burst width, count positive pulses, count
	math waveforms, reference waveforms	negative pulses, count falling edges, count
		rising edges, mean value, RMS cycle,
		RMS, mean cycle, peak peak, peak+,
		peak-, frequency, period, amplitude, top
		level, base level, positive overshoot,
		negative overshoot, pulse width+, pulse
		width-, duty cycle+, duty cycle-, rise time,
		fall time, delay, phase, crest factor, slew
		rate+, slew rate-, σ.std. deviation, σ.std.
		deviation cycle, delay to trigger
	measurements on trigger signal	trigger period, trigger frequency
		implemented by means of six-digit
		hardware counter
	reference levels	lower, middle and upper level in
		percentage
	statistics	maximum, minimum, mean, standard
		deviation and measurement count for each
		automatic measurement
	number of active measurements	8
Cursor	type	vertical, horizontal, vertical and horizontal, V-marker
	functions	x and y tracking, coupling of cursors, set to
		trace, two sources selectable
Quick measurements	function	fast overview of measurements from one
		channel,
		some measurements displayed with result
		lines in diagram
	sources	
	R&S®RTB22	channel 1, channel 2
	R&S®RTB24	channel 1, channel 2, channel 3, channel 4
	measurements displayed in diagram	mean, max. peak, min. peak, rise time, fall time
	numerically displayed measurements	RMS cycle, peak-to-peak voltage, period, frequency

Digital voltmeter

Accuracy		related to channel settings of voltmeter
		source
Measurements		DC, AC + DC (RMS), AC (RMS)
Sources	R&S®RTB22	channel 1, channel 2
	R&S®RTB24	channel 1, channel 2, channel 3,
		channel 4
Number of measurements		up to 4
Resolution		up to 3 digits
Bandwidth		1 MHz

Frequency counter

Measurements		frequency, period
Sources	R&S®RTB22	trigger signal source (edge, video): line, channel 1, channel 2, external trigger in
	R&S®RTB24	trigger signal source (edge, video): line, channel 1, channel 2, channel 3,
		channel 4, external trigger in
Number of measurements		2
Resolution		6 digits
Frequency range		0. 05 Hz to bandwidth of oscilloscope
		(limited by bandwidth of trigger filter)

Mask testing

Sources	R&S®RTB22	channel 1, channel 2
	R&S®RTB24	channel 1, channel 2, channel 3,
		channel 4
Mask definition		acquired waveform with user-defined
		tolerance, can be stored and restored
Result statistics		completed acquisitions, passed and failed acquisitions (absolute and in percent), test duration
Actions on mask violation		sound, acquisition stop, screenshot, save waveform, pulse out (AUX OUT connector)

Waveform maths

Number of math waveforms		up to 5
Functions		addition, subtraction, multiplication,
		division, square, square root, absolute
		value, reciprocal, inverse, log10, ln,
		derivation, integration, low pass, high
		pass, track period, track frequency, track
		pulse width, track duty cycle
Sources	R&S®RTB22	channel 1, channel 2,
		math waveforms 1 to 4
	R&S®RTB24	channel 1, channel 2, channel 3,
		channel 4, math waveforms 1 to 4
FFT	sources	
	R&S®RTB22	channel 1, channel 2, math waveforms,
		reference waveform
	R&S®RTB24	channel 1, channel 2, channel 3,
		channel 4, math waveforms, reference
		waveform
	setup parameters	start frequency, stop frequency, center
		frequency, frequency span, vertical scale,
		vertical position, resolution bandwidth,
		gate (time range and position)
	windows	Hanning, Hamming, Blackman,
		rectangular, flat top
	waveform arithmetic	none, min. hold, max. hold, average
		(selectable from 2 to 1024)
	scaling	dBm, dBV, dBμV, V (RMS)

Search function

Functions	search types	edge, width, peak, rise/fall time, runt, data2clock, pattern, protocol (available
		with R&S®RTB-K3 option)
		. ,
	configuration	manual level setting, adjustable hysteresis
	display of search events	in diagram (markers) and in result table
Sources	R&S®RTB22	channel 1, channel 2,
		math waveform, D0 to D15
	R&S [®] RTB24	channel 1, channel 2, channel 3,
		channel 4, math waveform, D0 to D15

Display characteristics

Diagram types	manually changeable vertical window size	Yt, XY, zoom, FFT
XY mode		parallel display of XY diagram and
		Yt diagrams of input signals for X, Y
Zoom		horizontal zoom with fast navigation, split
		screen with overview signal and zoomed
		signal
FFT mode		split screen with Yt diagrams and
		dedicated frequency diagram
Interpolation		sin(x)/x, linear, sample & hold
Waveform display		lines, dots only
Persistence		50 ms to 12.8 s, infinite
		inverse brightness, waveform color modes
Special display mode		for analog channels (temperature, fire,
		rainbow)
Diagram grid		lines, reticle, none, with annotation, track
		grid
Reference signals		up to 4 reference signals
Sources		analog and digital channels, math,
		reference, spectrum

Protocol and logic

Bus decode	number of bus signals	2 2
	bus types	parallel, parallel clocked
	R&S®RTB-K1 option	SPI (2-wire, 3-wire, 4-wire 2), I2C
	R&S®RTB-K2 option	UART/RS-232/RS-422/RS-485
	R&S®RTB-K3 option	CAN, LIN
	display types	decoded bus, logical signal,
		frame table (depends on decoded bus)
	data format of decoded bus	hex, decimal, binary

Miscellaneous

Save/recall	device settings	save and recall on internal file system or USB flash drive or on a PC via web interface or USB-MTP (media transfer protocol)
	reference waveforms	save and recall on internal file system or USB flash drive or on a PC via web interface or USB-MTP
	waveforms	save on USB flash drive or download and save on a PC via web interface or USB-MTP; available file formats: BIN, CSV, TXT float (MSB/LSB first)
	screenshots	save on USB flash drive or download and save on a PC via web interface or USB-MTP; available file formats: BMP, PNG

² If a bidirectional bus is used (e.g. UART RX/TX or SPI MOSI/MISO), two bus decoders are occupied.

Camera button (one touch)	configurable button, actions on press: • save device settings (setup)
	save waveforms
	 save screenshot
	search/bus/statistic results
Instrument security	secure erasure of internal file system and
	all settings
Menu languages	available menu languages:
	English
	German
	French
	Spanish
	Italian
	 Portuguese
	Czech
	Polish
	Russian
	Simplified Chinese
	Traditional Chinese
	Korean
	Japanese
Help	online help, available languages:
	English
Undo/redo	undo/redo function

Input and outputs

Front		
Channel inputs		BNC, for details see Vertical system
External trigger input		BNC, for details see Trigger system
AUX OUT (BNC)	trigger out	for details see Trigger system
	reference frequency	10 MHz ± 3.5 ppm (meas.)
	mask violation	pulse
	waveform generator (with R&S®RTB-B6 option only)	for details see Waveform generator
Probe compensation output	signal shape rectangle	V _{low} = 0 V, V _{high} = 2.5 V (meas.)
	frequency	1 kHz during probe adjust setup or manual configurable
Pattern source (with R&S®RTB-B6 option only)	P3 to P0 (with R&S®RTB-B6 option only)	4 lugs, for details see 4-bit pattern generator
Digital channel inputs	D15 to D8, D7 to D0	with R&S®RTB2-B1 option only
Ground lug		connected to ground
USB host interface		1 port, type A plug, version 2.0, USB drives only, FAT32 formatting required
Rear		
USB device interface		1 port, type B plug, version 2.0
Ethernet interface		1 port, 1 Gbit
Security slot		for standard Kensington style lock
Fixation loop		for securing the instrument with a cable

General data

Display		
Туре		10.1" WXGA display with capacitive touch
Resolution		1280 x 800 pixel (WXGA)
Temperature		
Temperature loading	operating temperature range	0 °C to +50 °C
	storage temperature range	–40 °C to +70 °C
Climatic loading		+25 °C/+40 °C at 85 % rel. humidity cyclic, in line with IEC 60068-2-30
Altitude		
Operating		up to 3000 m above sea level
Nonoperating		up to 4600 m above sea level
Mechanical resistance		
Vibration	sinusoidal	5 Hz to 150 Hz, max. 1.8 g at 55 Hz; 0.5 g from 55 Hz to 150 Hz, in line with EN 60068-2-6, MIL-PRF-28800F, 4.5.5.3.2 sinusoidal vibration, class 3 and 4
	random	10 Hz to 300 Hz, acceleration 1.2 g (RMS), in line with EN 60068-2-64, MIL-PRF-28800F, 4.5.5.3.1 random vibration, class 3 and 4
Shock		40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine
Maximum of sound pressure level		28.3 dB/30.2 dB (A) at 1.0 m/0.8 m distance (at +23 °C, 947 mbar (hPa), 20 % rel. humidity), in line with ISO EN 3744
EMC		
RF emission		in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emission requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments
Immunity		in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments ³
Certifications		VDE, _C CSA _{US}
Calibration interval		1 year
Power supply		
AC supply		100 V to 240 V at 50 Hz to 400 Hz, 0.95 A to 0.5 A
Power consumption		max. 60 W
Safety		in line with IEC 61010-1, EN 61010-1, CAN/CSA-C22.2 No. 61010-1-04, UL 61010-1
Power consumption in stand-by Mechanical data		0.5 W (meas.)
Dimensions	W×H×D	390 mm × 220 mm × 152 mm (15.4 in × 8.66 in × 5.98 in)
Weight (nom.)		2.5 kg (5.5 lb)

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³ Test criterion is displayed noise level within ±1 div for input sensitivity of 5 mV/div.

Options

R&S®RTB2-B1 mixed signal option

Vertical system		
Input channels		16 logic channels (D15 to D0)
Arrangement of input channels		arranged in two logic probes with 8 channels each, assignment of the logic probes to the channels D15 to D8 and D7 to D0
Input impedance		100 kΩ ± 2 % ~4 pF (meas.) at probe tips
Maximum input frequency	signal with minimum input voltage swing and hysteresis setting: normal	300 MHz (meas.)
Maximum input voltage		±40 V (V _p)
Minimum input voltage swing	hysteresis small	300 mV (V _{pp}) (meas.)
	hysteresis medium	800 mV (V _{pp}) (meas.)
	hysteresis large	1500 mV (V _{pp}) (meas.)
Threshold groups		D15 to D8 and D7 to D0
Threshold level	range	-2 V to 8 V in 10 mV steps
	predefined	CMOS 5.0 V, CMOS 3.3 V, CMOS 2.5 V, TTL, ECL
Threshold accuracy		±(100 mV + 3 % of threshold setting) (meas.)
Comparator hysteresis		small, medium, large
Horizontal system		
Channel-to-channel skew		max. 800 ps (meas.)
Acquisition system		
Sampling rate		1.25 Gsample/s for every channel
Memory depth	two logic probes (normal mode)	10 Msample for every channel
	one logic probe (interleave mode)	20 Msample for every channel
Trigger system		see Trigger system
Waveform measurements		
Measurement sources		all channels from D15 to D0
Automatic measurements		positive pulse width, negative pulse width period, frequency, burst width, delay, phase, positive duty cycle, negative duty cycle, positive pulse count, negative pulse count, rising edge count, falling edge count, value at the cursor position
Additional cursor function		display of decoded parallel bus value at the cursor position
Display characteristics		
Channel activity display		independent of the scope acquisition, the state (stays low, stays high or toggles) of the channels from D15 to D0 is displayed

R&S®RTB-B6 waveform generator and 4-bit pattern generator

Resolution		14 bit
Sample rate		250 Msample/s
Amplitude	level	
	high Z	20 mV to 5 V (V _{pp})
	50 Ω	10 mV to 2.5 V (V _{pp})
	accuracy (frequency ≤ 100 kHz)	3 %
DC offset	level	- - - - - - - - - -
	high Z	±2.5 V
	50 Ω	±1.25 V
	accuracy	3 % or ± 5 mV whatever is greater
Sine	frequency	0.1 Hz to 25 MHz
	SFDR	> 40 dBc (meas.)
	THD	> 40 dBc (meas.)
Rectangle	frequency	0.1 Hz to 10 MHz
Pulse	frequency	0.1 Hz to 10 MHz
	edge time	adjustable
	duty cycle	1 % to 99 %
Ramp, triangle, sinc, exponential	frequency	0.1 Hz to 1 MHz
Arbitrary	frequency	0.1 Hz to 10 MHz
and the state of t	memory depth	16 kpoints
Noise	bandwidth	max. 25 MHz
10.00	level	0 % to 100 % of signal amplitude
Modulation	AM	o /o to 100 /o of orginal amplitude
vioudiation	function	sine, rectangle, triangle, ramp
	frequency	0.1 Hz to 1 MHz
	depth	0 % to 100 %
	FM	
	function	sine, rectangle, triangle, ramp
	frequency	0.1 Hz to 1 MHz
	deviation	depends on modulation frequency
	ASK	depends on modulation frequency
	function	sine, rectangle, triangle, ramp
	frequency	0.1 Hz to 1 MHz
	ASK depth	0 % to 100 %
	FSK	0 % 10 100 %
	function	sine, rectangle, triangle, ramp
		0.1 Hz to 1 MHz
	frequency FSK rate	
Curan		0.1 Hz to carrier frequency/2
Sweep	start frequency	1 Hz to 25 MHz
	stop frequency	1 Hz to 25 MHz
	sweep time	1 ms to 10 s
D1	sweep type	linear, logarithmic, triangle
Burst	number of cycle	1 to 1024
	idle time	28 ns to 17 s
	start phase	0° to 360°
4 h. 14	trigger	continuous, manually
4-bit pattern generator		
Functions		probe adjust/square wave, bus signal
		source 4-bit counter, programmable 4-b
Draha adjust		pattern
Probe adjust		1 kHz/1 MHz square wave signal
Dave element element		approx. 2.5 V (V _{pp}) (tr < 4 ns)
Bus signal source	1 1 1 1 1 1	SPI, I ² C, UART, CAN, LIN
4.1%	bandwidth	9600 bit/s to 1 Mbit/s
4-bit counter	frequency	1 mHz to 25 MHz
Programmable pattern	sample rate	20 ns to 1 s, up/down
	memory depth	2048 bit
	pattern idle time	50 ns to 1 s

R&S®RTB-Bxx bandwidth upgrades

Option	Model	Analog bandwidth upgrade from 70 MHz to
R&S [®] RTB-B221	R&S [®] RTB22	100 MHz
R&S®RTB-B222	R&S [®] RTB22	200 MHz
R&S®RTB-B223	R&S [®] RTB22	300 MHz
R&S®RTB-B241	R&S [®] RTB24	100 MHz
R&S®RTB-B242	R&S [®] RTB24	200 MHz
R&S®RTB-B243	R&S®RTB24	300 MHz

R&S®RTB-K1

I ² C triggering and decoding Bus configuration	sources for SCL and SDA	channel 1, channel 2, channel 3,
bus configuration	Sources for SCL and SDA	channel 4, logic channels from D0 to D15
	bit rate	up to 10 Mbps
	size of address	7 bit or 10 bit
	size of data	8 bit
	label list	associate frame identifier with symbolic ID
Trigger	trigger events	start, stop, restart, missing acknowledge, address (7 bit or 10 bit), data, address and data
	offset for trigger on data	0 data byte to 4095 data byte
	data pattern width	up to 3 sequential data byte
Decode	displayed signals	bus signal, logic signal or both
	color coding of bus signal	address, data, start, stop, ACK, NACK;
		error and trigger event are displayed in different colors
	displayed format of address	hex
	displayed format of data	ASCII, binary, decimal or hex
SPI triggering and decoding		
Bus configuration	sources for CS, CLK, MOSI and MISO	channel 1, channel 2, channel 3, channel 4, logic channels from D0 to D15
	bit rate	up to 25 Mbps
	chip select (CS)	active low, active high or missing (two-wire SPI)
	clock (CLK) slope	rise or fall
	data symbol size	1 bit to 32 bit
	idle time for two-wire SPI	< 1 ms
Trigger	trigger events	start of frame, end of frame, bit number, data pattern
	selectable bit number	0 to 4095
	offset for trigger on data pattern	0 to 4095 bit
	data pattern size	1 bit to 32 bit
Decode	displayed signals	bus signal, logic signal or both
	color coding of bus signal	data, start, stop; error and trigger event are displayed in different colors
	displayed format of data	ASCII, binary, decimal or hex
	data decoding	MSB or LSB first

R&S®RTB-K2

UART/RS-232/RS-422/RS-485	triggering and decoding	
Bus configuration	source for RX and TX	channel 1, channel 2, channel 3,
	bit rate	channel 4, logic channels from D0 to D15 300/600/1200/2400/4800/9600/19200/
	bit rate	38400/57600/115200 bps or
		user-selectable up to 3 Mbps
	end of frame	timeout, none
	signal polarity	idle low, idle high
	data symbol size	5 bit to 9 bit
	parity	none, even or odd
	stop bits	1, 1.5 or 2
Trigger	trigger events	start bit, start of frame, symbol number,
		any symbol, pattern of symbols, parity
		error, frame error, break
	offset for trigger on data symbol	0 to 4095 symbols
	data symbol pattern width	1 to floor (32/symbol size) symbols
Decode	displayed signals	bus signal, logic signal or both
	color coding of bus signal	data, start, stop; error and trigger event are displayed in different colors
	displayed format of data	ASCII, binary, decimal or hex

R&S®RTB-K3

CAN triggering and decoding Bus configuration	signal type	CAN_H, CAN_L
3	sources	channel 1, channel 2, channel 3,
		channel 4, logic channels from D0 to D15
	bit rate	10/20/33.3/50/83.3/100/125/250/500/
		1000 kbps or user-selectable in range
		from 100 bps to 2 Mbps
	sampling point	10 % to 90 % within bit period
	label list	associate frame identifier with symbolic ID
Trigger	trigger events	start of frame, frame type, identifier,
		identifier + data, error condition (any
		combination of CRC error, bit stuffing
		error, form error and ACK error)
	identifier setup	frame type (data, remote or both),
		identifier type (11 bit or 29 bit);
		condition =, ≠, >, <; identifier selectable
		from label list
	data setup	data pattern up to 8 byte (hex or binary);
		condition =, ≠, >, <
Decode	displayed signals	bus signal, logic signal or both
	color coding of bus signal	start of frame, identifier, DLC, data
		payload, CRC, ACK, end of frame, error
		frame, overload frame, CRC error, bit
		stuffing error, ACK error
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list,
		errors highlighted in red; three table
		positions (top, bottom, full screen); frame
		navigation; data export as CSV file

Version 01.01, November 2024

Search	search events	frame, error, identifier, identifier + data, identifier + error
	frame event setup	start of frame, end of frame, overload frame, error frame, data ID 11 bit, data ID 29 bit, remote ID 11 bit, remote ID 29 bit
	error event setup	any combination of CRC error, bit stuffing error, form error and ACK error
	identifier setup	frame type (data, remote or both), identifier type (11 bit or 29 bit); condition =, \neq , >, <; identifier selectable from label list
	data setup	data pattern up to 8 byte (hex or binary); condition =, \neq , >, <
	event table	search results displayed as tabulated list; event navigation

LIN triggering and decoding		
Bus configuration	version	1.3, 2.x or SAE J2602; mixed traffic is supported
	bit rate	1.2/2.4/4.8/9.6/10.417/19.2 kbps or user-selectable in range from 1 kbps to 2.5 Mbps
	polarity	active high or active low
	label list	associate frame identifier with symbolic ID
Trigger	source	any input channel
	trigger events	start of frame (sync break), identifier, identifier + data, wakeup frame, error condition (any combination of checksum error, parity error and sync field error)
	identifier setup	range from 0d to 63d; condition =, ≠, >, <; identifier selectable from label list
	data setup	data pattern up to 8 byte (hex or binary); condition =, \neq , >, <
Decode	displayed signals	bus signal, logic signal or both
	color coding of bus signal	frame, frame identifier, parity, data payload, checksum, error condition
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list, errors highlighted in red; three table positions (top, bottom, full screen); frame navigation; data export as CSV file
Search	search events	frame, error, identifier, identifier + data, identifier + error
	frame event setup	start of frame, wake up
	error event setup	any combination of checksum error, parity error and sync field error
	identifier setup	range from 0d to 63d; condition =, ≠, >, <; identifier selectable from label list
	data setup	data pattern up to 8 byte (hex or binary); condition =, \neq , >, <
	event table	search results displayed as tabulated list; event navigation

R&S®RTB-K15 history and segmented memory

This is a standard functionality Memory segmentation	function additional memory segments for the				
memory degineritation	ranouon	acquisition			
	number of segments ⁴	record length	segments	total memory	
			(up to)	(per channel)	
		10 ksample	13 107	131 Msample	
		20 ksample	13 107	262 Msample	
		50 ksample	4 369	218 Msample	
		100 ksample	2 621	262 Msample	
		200 ksample	1 456	291 Msample	
		500 ksample	624	312 Msample	
		1 Msample	319	319 Msample	
		2 Msample	159	318 Msample	
		5 Msample	64	320 Msample	
		10 Msample	32	320 Msample	
		20 Msample	16	320 Msample	
	Segmentation is active on all ana spectrum analysis.	log and logic channels, p	rotocol deco	ding and	
Fast-segmented mode	-1	ns in acquisition memory	without inter	runtion due to	
r ast-segmented mode	continuous recording of waveforms in acquisition memory without interruption due to visualization; blind time between consecutive acquisitions less than 2.5 µs				
	(up to 300 000 waveforms/s)				
History mode	function	The history mode always provides access t			
			past acquisitions in the segmented memory		
	timestamp resolution	6.4 ns			
	history player replays the recor			ded waveforms; start and	
			stop waveform could be set; repetition		
	possible				

R&S®RTB-K36

Frequency response analysis (B	ode plot)	
Stimulus	frequency mode	single sweep or repeated sweep
	frequency range	10 Hz to 25 MHz
	amplitude mode	fixed or amplitude profile
	amplitude level	20 mV to 5 V into high Z
		10 mV to 2.5 V into 50 Ω
Input and output sources	R&S®RTB22	channel 1, channel 2
	R&S®RTB24	channel 1, channel 2, channel 3, channel 4
Number of test points		10 points to 500 points per decade
Dynamic range		> 70 dB (typ.) based on 0 dBm
		(630 mV (V_{pp})) into 50 Ω ,
		gain noise < 1 dB, phase noise < 5°
Measurement		dual pair of tracking gain and phase cursors
Diagram types	manually changeable vertical window size	parallel display of result window and input
		and output signal view
Result table		navigation and export functions
Scaling	during and after test	auto-scale and manual scaling and
		positioning

⁴ In interleaved mode.

Ordering information

Designation	Туре	Order No.
Choose your oscilloscope base model		
Oscilloscope, 70 MHz, 2 channels	R&S®RTB22	1333.1005.02
Oscilloscope, 70 MHz, 4 channels	R&S®RTB24	1333.1005.04
Base unit, includes: R&S®RTB-B6 arbitrary waveform generator; R&	S®RTB-K15 history and segmente	ed memory,
Standard accessories: 300 MHz passive probe per channel, power of	ord, getting started manual and s	afety instructions
Choose your bandwidth upgrade		
Upgrade of R&S®RTB22 oscilloscopes to 100 MHz bandwidth	R&S®RTB-B221	1333.1163.02
Upgrade of R&S®RTB22 oscilloscopes to 200 MHz bandwidth	R&S®RTB-B222	1333.1170.02
Upgrade of R&S®RTB22 oscilloscopes to 300 MHz bandwidth	R&S®RTB-B223	1333.1186.02
Upgrade of R&S®RTB24 oscilloscopes to 100 MHz bandwidth	R&S [®] RTB-B241	1333.1257.02
Upgrade of R&S®RTB24 oscilloscopes to 200 MHz bandwidth	R&S®RTB-B242	1333.1263.02
Upgrade of R&S®RTB24 oscilloscopes to 300 MHz bandwidth	R&S®RTB-B243	1333.1270.02
Choose your options	1	,
MSO, set of 2 logic probes, 300 MHz	R&S®RTB2-B1	1801.8421.02
I ² C/SPI serial triggering and decoding	R&S®RTB-K1	part of R&S®RTB2-PK1
UART/RS-232/RS-422/RS-485 serial triggering and decoding	R&S®RTB-K2	part of R&S®RTB2-PK1
CAN/LIN serial triggering and decoding	R&S®RTB-K3	part of R&S®RTB2-PK1
Frequency response analysis (Bode plot)	R&S®RTB-K36	part of R&S®RTB2-PK1
Application bundle, consists of the following options:	R&S®RTB2-PK1	1801.8438.02
R&S®RTB-K1, R&S®RTB-K2, R&S®RTB-K3, R&S®RTB-K36		100110100102
Choose your additional probes		
Single-ended passive probes		
300 MHz, 10:1, 10 MΩ, 400 V (RMS), 12 pF	R&S®RT-ZP03S	1803.1001.02
500 MHz, 10:1, 10 MΩ, 300 V (RMS), 10 pF	R&S®RT-ZP05S	1333.2401.02
500 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF	R&S®RT-ZP10	1409.7550.00
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF	R&S®RT-ZP1X	1333.1370.02
High voltage single-ended passive probes	1	L
250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF	R&S®RT-ZH03	1333.0873.02
400 MHz, 100:1, 50 MΩ, 1000 V, 7.5 pF	R&S®RT-ZH10	1409.7720.02
400 MHz, 1000:1, 50 MΩ, 1000 V, 7.5 pF	R&S®RT-ZH11	1409.7737.02
Current probes	,ac <u>_</u>	1 10011 101102
20 kHz, AC/DC, 10 A/1000 A	R&S®RT-ZC02	1333.0850.02
100 kHz, AC/DC, 30 A	R&S®RT-ZC03	1333.0844.02
10 MHz, AC/DC, 150 A	R&S®RT-ZC10	1409.7750.02
100 MHz, AC/DC, 30 A	R&S®RT-ZC20	1409.7766.02
120 MHz, AC/DC, 5 A	R&S®RT-ZC30	1409.7772.02
Power supply for current probes	R&S®RT-ZA13	1409.7789.02
Logic probe (MSO)	riae iii ziie	1100.1700.02
Active 8 channel logic probe	R&S®RT-ZL03	1333.0715.02
Probe accessories	1.00 1.11 2200	1000.07 10.02
50 Ω feedthrough termination	R&S®HZ22	3594.4015.02
Probe pouch	R&S®RT-ZA19	1335.7875.02
Choose your accessories	NGO INT-ZATO	1000.7070.02
Front cover	R&S®RTB-Z1	1333.1728.02
Soft case	R&S®RTB-Z3	1333.1726.02
Transit case	R&S®RTB-Z4	1335.9290.02
Rackmount kit	R&S®ZZA-RTB2K	1333.1711.02

Warranty and service

Warranty		
Base unit		3 years
All other items		1 year
Service options		
	Service plans	On demand
Calibration	up to five years 5	pay per calibration
Warranty and repair	up to five years 5	standard price repair
Contact your Rohde & Schwarz sales office for	further details.	

⁵ For extended periods, contact your Rohde & Schwarz sales office.

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